CLAIMS

1. Method for measuring the distance of an object from a measuring device, comprising the following steps:
a) emitting a signal;
5 b) directing the signal towards an object;
c) detecting the signal diffused by the object;
d) comparing the detected signal with the emitted signal so as to obtain a comparison signal representing the distance travelled by the emitted signal and the object
10 diffused signal;
characterized in comprising the steps of:
e) carrying out before step a) a measuring device calibration step so as to associate to a prefixed comparison signal value a prefixed distance value;
15 f) identifying the distance value associated, in the previous calibration step, to the value of said comparison signal obtained in step d);
g) associating the distance value identified in step f) to the comparison signal obtained in step d).

20 2. Method according to claim 1, further comprising the following steps:
- carrying out at least one scan on the object along at least one scanning line;
- measuring the distance of a plurality of points on
25 the scanning line.

3. Method according to claim 1, wherein the emitted signal is a light beam adapted to illuminate the object along an emission optical path and the detected signal is an analogue electric signal proportional to the luminous
30 image diffused by the object along a receiving optical path.

4. Method according to claim 3, comprising the following steps:
a1) carrying out at least one scan on the object along at
35 least one scanning line;

b1) acquiring the analogue electric signal representative of the luminous image diffused by the object along the scanning line;

c1) carrying out a sampling of the analogue electric signal at a prefixed sampling frequency so as to extract at least one sample x_k representative of at least one point of the scanning line;

d1) converting the sampled analogue signal into digital signal so as to obtain a numerical value of said at least one sample x_k;

wherein, in the calibration step, a numerical value and a distance value is associated to a prefixed sample, and comprising, in addition, the following steps:

f1) identifying the distance value which, in the previous calibration step, had been associated to said numerical value obtained in step d1), and to said sample x_k;

g1) associating the distance value identified in step f1) to the numerical value obtained in step d1).

5. Method according to claim 4, comprising the additional step of h) storing the distance value obtained for sample x_k in step g1) and iteratively repeating the previous steps starting from step d1) for each further sample x_{k+1}, wherein k=1,..,N.

6. Method according to claim 4, wherein the calibration step comprises the following steps:

- carrying out at least one scan along a scanning line on a surface of known reflectance placed at a prefixed distance;

- acquiring an analogue electric signal representative of the reflectance of said surface along the scanning line;

- carrying out a sampling of the acquired analogue signal, at a sampling frequency equal to the one prefixed, so as to extract at least one sample x_j representative of at least one point on the scanning line;

- converting the sampled analogue signal into digital signal so as to obtain a numerical value for said at least one sample x_j;

- associating to said numerical value obtained for said
5   at least one sample x_j the prefixed distance value at which the surface of known reflectance has been placed, and iteratively repeating the previous steps for a prefixed number of times, each time moving the surface of known reflectance by a prefixed distance interval.

10   7. Method according to claim 1, wherein the calibration step comprises the following steps:

- carrying out the measurement of the distance of at least one reference means of known reflectance placed at a prefixed distance from the measuring device, thus
15   acquiring at least one electric signal representative of said distance;

- associating to the above electric signal the value of the prefixed distance at which the reference means of known reflectance has been placed, and iteratively
20   repeating the previous steps for all the reference means of known reflectance placed at the prefixed distances.

8. Method according to claim 6, wherein a plurality of scans of the surface of known reflectance are carried out along the scanning line, and a plurality of samples x_j
25   are extracted for each scan, where $j=1,..,N$, and further comprising the following steps:

- obtaining a mean scan of the plurality of scans effected;

- processing the mean scan so as to obtain said
30   numerical value for said at least one sample x_j.

9. Method according to claim 8, wherein the mean scan is obtained by calculating the arithmetical mean of the numerical values obtained for each sample x_j in the various operations of scanning effected.

35   10. Method according to claim 8, wherein the calibration

step also comprises the step of filling with the distance values associated to the numerical values obtained for the samples x_j, the items of a calibration matrix having, as index of column j a number from zero to the number of samples x_j extracted, and as index of row i, a number from zero to the maximum value of the numerical value obtained after the analogue to digital conversion of the signal.

11. Method according to claim 10, further comprising the step of providing the matrix with a number of items (i, j) higher than the number of samples x_j, and filling the empty items (i, j) of the matrix.

12. Method according to claim 11, wherein the step of filling the empty items (i, j) of the matrix comprises the step of identifying, column by column, the empty items (i, j) of the matrix and filling each of these empty items with a value obtained by linearly interpolating between the two numerical values differing from 0 that are nearer to the empty item, and belonging to the same column.

13. Method according to claim 4, comprising the step of associating to said at least one sample x_j a respective linear position on the scanning line.

14. Method according to claim 13, wherein the step of associating to the sample x_j a respective linear position on the scanning line comprises the following steps:
- positioning on the scanning line, at a prefixed distance, a grid composed of alternated light and dark equally-spaced intervals having known dimension;
- detecting the intervals of the grid in sequence, storing each time the time needed to travel each interval of the grid, in an item of a calibration table;
- summing up each time all the items stored until that moment starting from the first one up to reach a known prefixed value representing the time at which a prefixed

sample is generated;

-    identifying the position of sample x_j on the scanning line as that point of the scanning line having a distance value from the scan starting point equal to the value
5   obtained by the previously effected sum.

15. Method according to claim 1, further comprising the step of reading an optical code placed on the object.

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